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Posted Date: 10 June 2024

doi: 10.20944/preprints202406.0477.v1

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Article

Discussion and Demonstration of RF-MEMS Attenuators Design Concepts and Modules for Advanced Beamforming in the Beyond-5G and 6G Scenario—Part 2

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Abstract: In this paper, different concepts of reconfigurable RF-MEMS attenuators for beamforming applications are proposed and critically assessed. Capitalizing on the previous part of this work, the 1-bit attenuation modules featuring series and shunt resistors and low-voltage membranes (7-9 V) are employed to develop a 3-bit attenuator for fine-tuning attenuations (< -10 dB) in the 24.25-27.5 GHz range. More substantial attenuation levels are investigated by means of fabricated samples of coplanar waveguide (CPW) sections equipped with Pi-shaped resistors aiming at attenuations of -15, -30, and -45 dB. The remarkable electrical features of such configurations, showing flat attenuation curves and limited return losses, and the investigation of a switched-line attenuator design based on them led to the final proposed concept of a low-voltage 24-state attenuator. Such simulated device combines the Pi-shaped resistors for substantial attenuations with the 3-bit design for fine-tuning operations, showing a maximum attenuation level of nearly -50 dB while maintaining steadily flat attenuation levels and limited return losses (< -11 dB) along the frequency band of interest.

Keywords: RF-MEMS; attenuators; low actuation voltage; beamforming; 5G; B5G

1. Introduction

Variable attenuators are fundamental components of modern Radio Frequency (RF) systems to modify the signal power while maintaining signal integrity. As compared to variable amplifiers, variable attenuators provide a higher linearity and a low power consumption [1]. Among their common applications, it is worth mentioning broadband vector modulators [2] and impedance matching networks [3], measurement equipment [4], and automatic gain control amplifiers of RF front ends and transceivers [5]. In such contexts, variable attenuators may adjust or modulate the signal strength (RF applications) [6], or isolate ports and parts of the circuitry that are sensitive to a specific amount of power (duplex systems and measurement equipment) [7].

In the current telecommunication scenario, variable attenuators play a crucial role in the Multiple-Input-Multiple-Output (MIMO) systems [8], onto which the radio access to the 5G network is based [9]. In fact, in both base stations and small cells [10], the use of such phased-array antenna systems is meant to improve the communications by means of beamforming, which consists in the modification of the radiation pattern of the whole antenna system. Beamforming is operated by varying the amplitude and the phase of the signal fed to each radiating element of the phased array [11]. While phase shifters are crucial to control the orientation of the radiation pattern, attenuators are crucial to the control of its shape [12].

A proper beamforming is crucial on the receiver's side to reduce the impact of interfering signals coming from other directions [13], which translates into, a radiation pattern characterized by a main and narrow radiation lobe, with sidelobes of minimal amplitude. Arrays with a uniform element

amplitude display a high sidelobe level (SLL) (i.e., -13.2 dB [14]), so that the tapering of the element amplitude is introduced to reduce the SLL [15]. Wide tuning ranges are required for a substantial SLL reduction, whereas fine tuning resolutions are required for low quantization errors due to the tapering [16]. As an example, a tapering range of 21 dB is necessary to enforce a -30 dB SLL reduction according to Taylor's tapering method [17]. In addition, a high number of radiating elements implies the need for components characterized by a reduced power consumption [18] and minimal losses, and high miniaturization due to the small wavelengths [19,20].

Variable attenuators realized by means of RF Micro Electro-Mechanical Systems (RF-MEMS) are gaining an increasing popularity since the abovementioned features can be effectively addressed by such technology [21–23]. Digital [24] and analog [16] architectures have been explored for the developed RF-MEMS attenuators, with digital being the predominant choice [25]. Key sought-after attributes for these devices include reconfigurability, broadband performance, and excellent linearity [26]. Efforts in research have focused on expanding the range of attenuation levels while ensuring consistent impedance characteristics across various frequencies and minimal deviation from the desired attenuation level.

Concerning the related scientific literature, most of the RF-MEMS attenuators rely on Coplanar Waveguide (CPW) transmission lines, featuring metallic membranes actuated by electrostatic principle. The membranes generally connect or disconnect the signal line to resistive loads, such as series, shunt [27], or other configurations of resistors (e.g. T- or Pi-shaped [28,29]) in devices consisting of single or multiple cascaded units [30]. Sometimes, units consisting of different signal lines, generally an unloaded line and a line equipped with fixed loads selected by switches, are cascaded [31]. The maximum attenuation levels achieved by the existing devices reach up to -20 [24], -45 [32] or -70 dB [29], usually by 3- or 4-bit arrangements [23,29], with some elaborated examples featuring 8 bits [32]. The achieved attenuation errors are generally small, ranging within a range of (0.2-5) % as compared to the target value [2,28]. The attenuation steps realized by the existing devices vary based on the architecture, with the analog implementations showing the smallest steps (0.2 dB in [20]) and digital ones showing more substantial steps, such as 5 and 10 dB in [28] and [29], respectively. In terms of operational bandwidth, many examples cover the (0-20) GHz interval [28], while others touch 40 GHz [33] or even 80 GHz [32], demonstrating propensity for millimeter-wave (mm-Wave) applications.

Despite such valuable features, the existing and general-purpose devices show two restrictions: in some cases, a large footprint, and always a substantial bias voltage. In fact, the pursue of devices with many attenuation states led to footprints reaching $2.15 \times 7.5 \text{ mm}^2$ [24] or $8.28 \times 2.37 \text{ mm}^2$ [30] that can hardly fit in practical mm-wave MIMO systems (e.g., the footprint of the radiating elements of [34,35]), while the integration of devices with driving voltages of tens of Volts with common components implies the use of step-up converters, increasing costs, the design complexity, and the footprint of such systems. In this regard, commercial RF-MEMS variable attenuators often have reduced bias voltages (e.g., 3.3 V in [36]).

In this paper, we propose a compact 3-bit attenuator module for beamforming applications in the (24.25-27.5) GHz range, for fine-tuning attenuations (up to -10 dB) and low driving voltages, and a concept of switched-line attenuator module for more substantial levels, which can be complementary to the former to expand the maximum achievable attenuation. Capitalizing on the previous part of this work [37], describing basic building blocks of cells based on series and shunt resistors and membranes with low actuation voltage, a compact layout featuring a driving voltage of 7 V and switched resistors in a sort of Pi-shaped deployment is developed and critically assessed. Moreover, fabricated samples of fixed Pi-shaped resistors targeting higher attenuation levels (-15 dB, -30 dB, and -45 dB) has been characterized, together with a design of 2-bit switched-line attenuation module employing such resistors and operated by a larger driving voltage (~45 V), which suggested its potential to expand the capabilities of the previous module, upon a proper design refinement. In fact, the coarse design of the geometrical discontinuities of such switched-line attenuator module (i.e. the T-junctions and the 90° bends) limited its employment to frequency bands up to 20 GHz. However, the potential of such switched-line design is corroborated by the subsequent improved

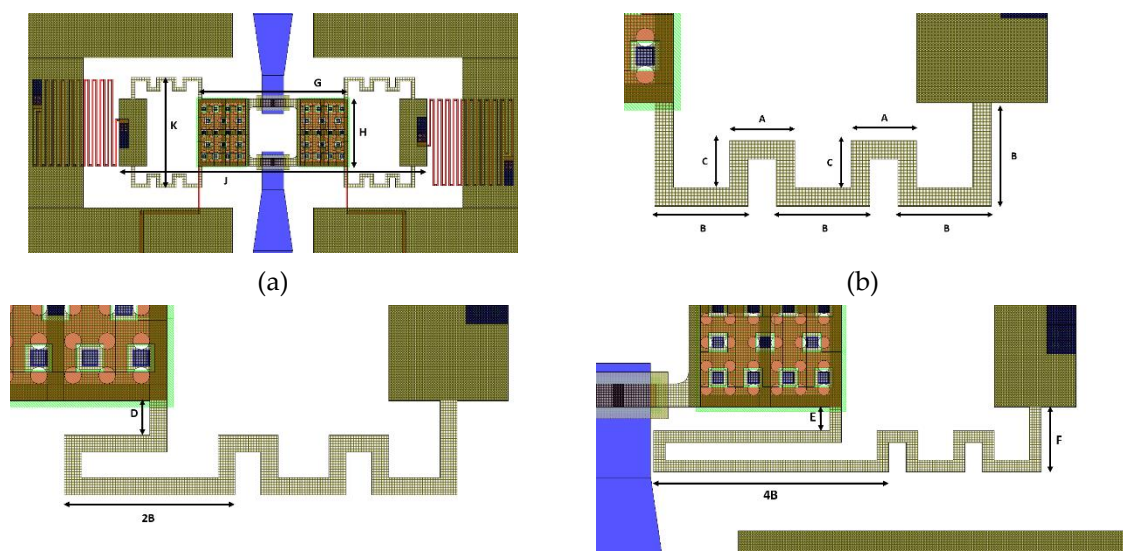
design, characterized by an optimized Single-Pole-Double-Throw (SPDT) with a 7 V actuation voltage, that is combined with the initially described 3-bit attenuator in a simulated arrangement featuring 24 possible attenuation levels, reaching -48.14 dB without any significant degradation of the overall electrical features of the resulting device. The proposed device combines different advantages, ranging from the reduced actuation voltage up to the remarkable reconfigurability, simultaneously providing fine-tuning capabilities and substantial maximum attenuation levels.

This paper is organized as follows: a brief description regarding the electromechanical features of the membranes considered for the development of the 3-bit compact attenuator is reported in Section 2, while in Section 3, the development and the simulated performance of the proposed 3-bit attenuator are assessed in relation to the real case scenario. In Section 4, samples of Pi-shaped resistors are considered for substantial attenuation levels, together with the concept 2-bit switched line module adopting such Pi-shaped resistors. Finally, Section 5 describes the combination of the proposed modules in a single conceptual integration of low-voltage multi-state attenuator, while final remarks and considerations are provided in Section 6.

2. The Low Pull-in Membranes

The selected class of membranes utilizes meandered supports to lower the spring constant in the vertical direction for the movable structure, thereby decreasing the required actuation voltage (or pull-in). Among the most fundamental layers that can be traced in the layouts reported in Figure 1, it is possible to notice the Polysilicon (in red) forming the decoupling resistors and the buried electrodes under the square areas of the movable membranes. It is also possible to notice the interrupted sections of the RF signal line, realized by the buried multi-metal layer (in blue), which also constitute the square pillars (Figure 1d) that are meant to stop the membrane upon the actuation and prevent the direct contact between the membrane and the underlying exposed electrodes. Rectangular areas of evaporated Gold are deployed in correspondence of the interrupted sections of the RF signal line (Figure 1d), forming the landing areas onto which the membrane will establish ohmic contact after the actuation. Concerning the movable membranes, a first layer of electroplated Gold forms the movable structure, whereas a second and thicker layer of Gold provides an enhanced stiffness to the anchor points and to the central plate, as visible in Figure 1b.

The chosen type of membranes features beams with uniform meanders, except the terminal beam, which has been extended in two variants to achieve a gradually reduced pull-in voltage. In fact, the three considered variants have in common a suspended structure with the same footprint ($780 \times 270 \mu\text{m}^2$), but while the first variant (Dev1) is characterized by uniform meanders (Figure 1a,b), the terminal meander of the second (Dev2) and third (Dev3) variants has been stretched to achieve a reduced pull-in voltage without increasing the overall area. The dimensional features of the membranes are highlighted in Figure 1 and summarized in Table 1.



(c) (d)

Figure 1. (a) Top view and (b) magnified view representing the beams of the first variant (Dev1), (c) magnified view of the second (Dev2) and (d) third variant (Dev3).

Table 1. Dimensional features of the discussed class of membranes.

Parameter	Value [μm]	Parameter	Value [μm]
A	35	B	50
C	25	D	15
E	20	F	55
G	380	H	170
J	780	K	270

The discussed membranes have been employed in the simple Single-Pole-Single-Throw switch configuration of Figure 1 as their simplest configuration, and the measurements on their fabricated samples have been compared to the simulation outcomes displayed in Figure 3, obtained by Finite Elements Method (FEM) in the Ansys Workbench software environment. The measurements were conducted by measuring the resistance drop along the RF signal line, passing from a substantial value (open circuit) to a minimal one (closed circuit) upon the actuation of the membrane.

Concerning the comparison displayed in Figure 2, it is possible to notice a good agreement between the simulated and the measured electro-mechanical behavior of the devices. In fact, considering that the driving voltage has been provided by 1 V steps, the measured behavior of Dev2 coincides with the simulated one, while the measured pull-in of Dev1 and Dev3 (7 V and 9 V, respectively) are moderately higher than the simulated ones (5 V and 8 V, respectively). More detailed considerations concerning the abovementioned membranes can be found in previous and more focused works [38].

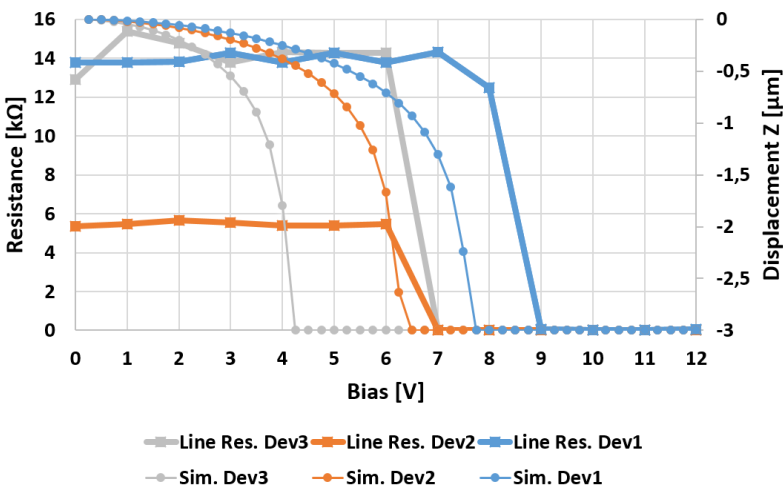


Figure 2. Simulated pull-in voltage of the three discussed membranes (dot marks) and their measured pull-in voltage by resistance drop along the RF signal line (square marks).

3. Low Pull-in Series and Shunt Attenuation Cells

In the previous part of this work, we explored the potential of basic attenuation modules equipped with the discussed class of membranes characterized by a low pull-in voltage. In particular, single modules featuring series and shunt resistors as the ones of Figure 3a,b have been critically addressed, showing that the series modules could be effectively adopted to achieve attenuation levels of about -3 dB, whereas the shunt modules can introduce attenuation levels up to nearly -5 dB. However, due to their overall compactness, they could be the basic building block of more complex multi-state attenuators.

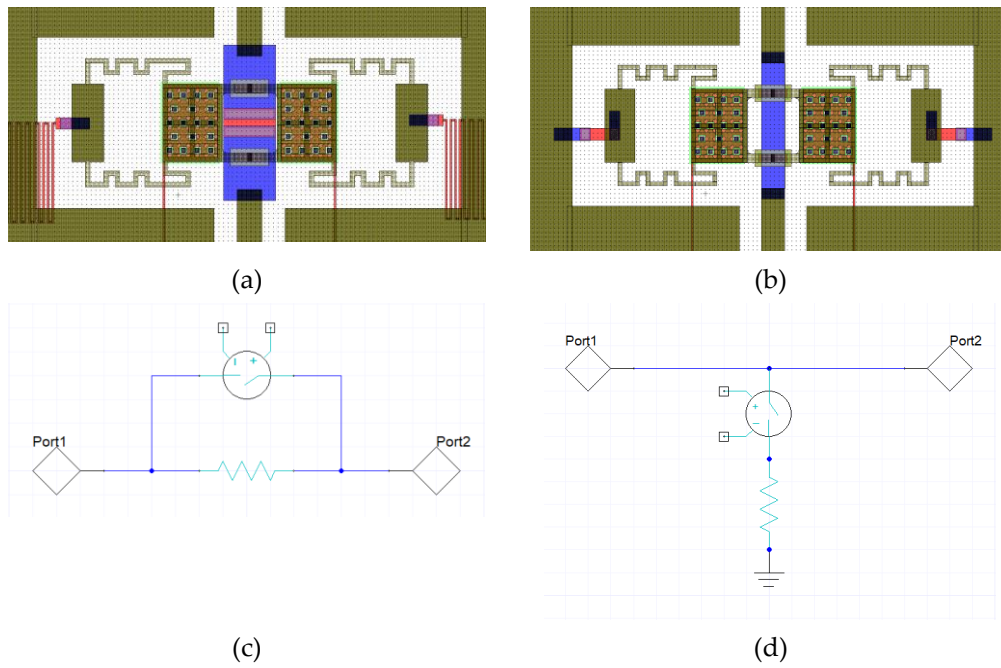


Figure 3. (a) Basic attenuator module based on a series resistor, (b) basic attenuator module based on two shunt resistors, (c) equivalent circuit topology of the series module, in which the resistor is short-circuited upon the actuation of the membrane, and (d) equivalent circuit topology of the shunt module.

The working principle of those kinds of attenuation cells is demonstrated by a circuital simulation in Cadence AWR Design Environment 22.1, where a section of CPW line is loaded by a resistor, series or shunt, Figure 4a,b respectively. The CPW line has a nominal length of 5 mm, and the resistor is considered ideal: zero length and without any imaginary part (i.e., nor capacitive nor inductive behavior). The activation of the resistor is commanded by the movement of the membranes. The choice of using two shunt resistors is motivated by having a symmetric configuration along the longitudinal axes of the device that facilitates the control of the input impedance of the device. Different geometrical arrangements and more sophisticated configurations can be considered based on the specific requirements tailored to the overall system performance.

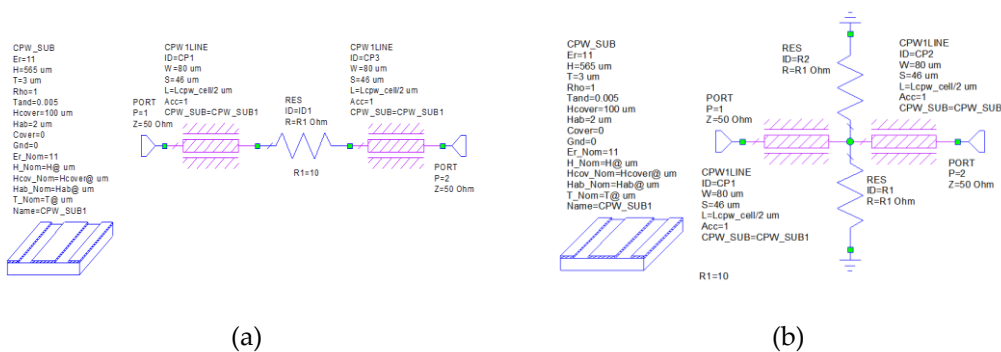


Figure 4. Circuital model of the basic attenuator module based on: (a) one series resistor, (b) on two shunt equal resistors.

As a proof of concept for the working principle, we show the behavior in terms of Insertion Loss (S_{21} parameter) as a function of the value of the resistor, for the two configurations described before. The results for the series configuration are reported in Figure 5, while the results related to the shunt configuration are displayed in Figure 6. It is observed that the different values of the resistor allow the tuning of the attenuation level of the CPW section. According to those operating principles, the resistors can be designed for the on-wafer/on-chip realization.

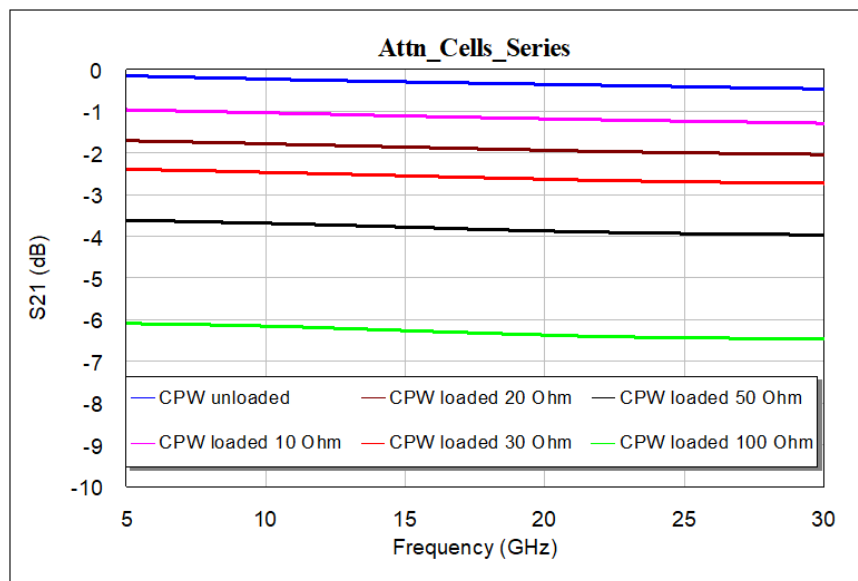


Figure 5. Behavior of the Insertion Loss for the CPW loaded by a series resistor, as a function of the resistor value.

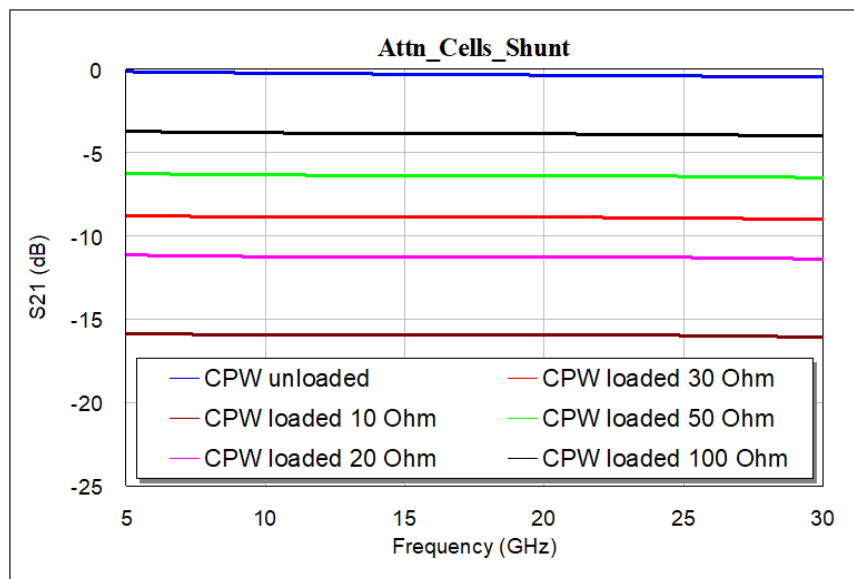


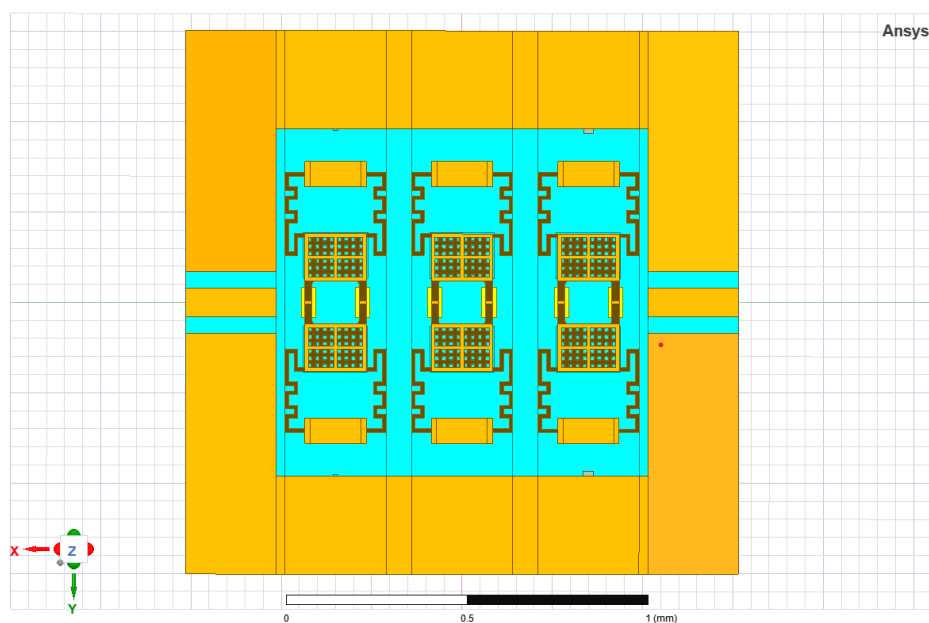
Figure 6. Behavior of the Insertion Loss for the CPW loaded by two equal shunt resistors, as a function of the resistor value.

In order to show the potential of the abovementioned 1-bit attenuation cells characterized by a low actuation voltage introducing a fine-tuning in the range of few dBs, a reconfigurable 3-bit attenuator has been designed and optimized. As visible in Figure 7 (a), it is composed by three cascaded cells, whose spacing between the cells (70 μm) and between the cells and the bordering ground planes (25 μm) has been optimized for the frequency range of interest. The same applies for the displayed CPW line, whose width and gaps are 79 μm and 46 μm , respectively. Concerning the employed membranes, the model characterized by a 7 V pull-in (Dev2 in Figure 2) has been chosen,

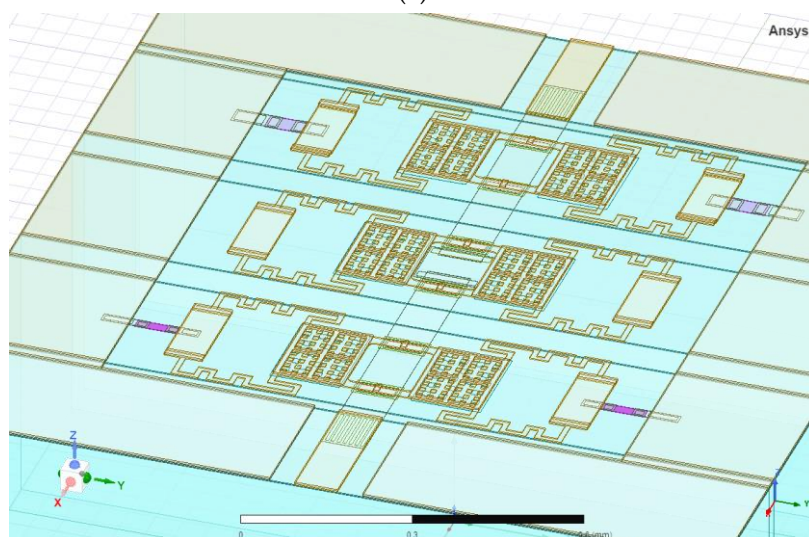
since it represents a good trade-off between its electromechanical and electrical performances. The resulting device exhibits a remarkable compactness, having an overall footprint of $1.53 \times 1.5 \text{ mm}^2$.

Regarding the operational bandwidth of the device, the 24.25-27.5 GHz frequency interval has been selected as practical case, since it is the portion of spectrum allocated to 5G communications in Europe (Frequency Range 2, N258 band).

The initial guideline chosen during the optimization of the device was to achieve for each resistor a substantial value of attenuation, of about -3 dB, possibly maintaining an overall symmetry between the two lateral shunt cells. However, the optimization process highlighted the need to reduce the amount of attenuation introduced by the shunt resistors in correspondence of the input port, to mitigate the amount of the reflected power when the closest shunt cell is activated individually or in combination with the series one. As a result, the shunt resistors close to the intended input port have been dimensioned differently (lower pair in Figure 7b), making such device electrically asymmetric. In fact, while the shunt resistors close to the input port have an $80 \times 20 \text{ }\mu\text{m}^2$ (length x width) area, the other shunt ones measure $71 \times 36 \text{ }\mu\text{m}^2$, and their sheet resistances are 60 and 190 Ohm/Sq, respectively. For the sake of completeness, 80 Ohm/Sq sheet resistance has been chosen for the series resistor, resulting in a $103 \times 117 \text{ }\mu\text{m}^2$ solid.



(a)

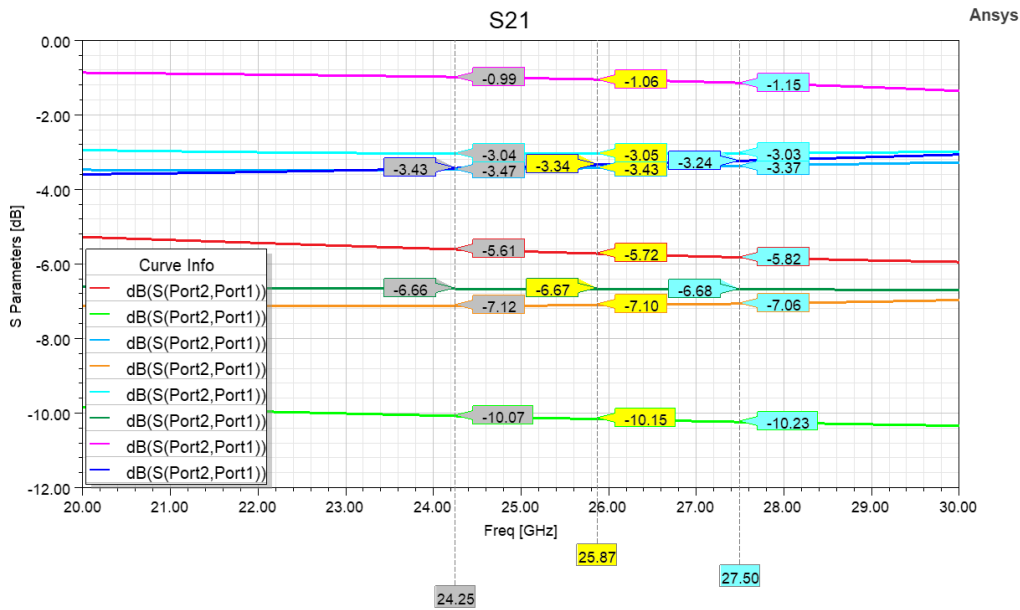


(b)

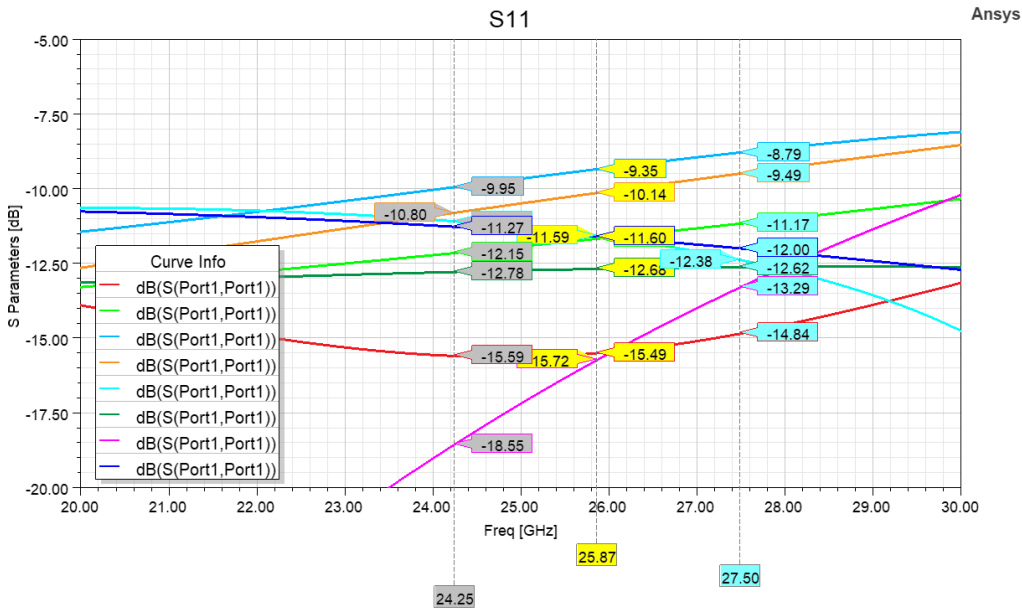
Figure 7. (a) Top view of the 3-bit reconfigurable attenuator, featuring a central series cell and lateral shunt cells, and (b) detail of the optimized resistors, with the thinner ones (left cell) neighboring the input port.

The following considerations about the electromagnetic behavior of the device are based on the simulation outcomes obtained by Finite Elements Method (FEM) in the Ansys High Frequency Structure Simulator (HFSS) software environment. Concerning the electrical features reported in Figure 8a, it is possible to notice that the attenuation levels realized by the device cover an interval of about 9 dB, from the basic -1.06 dB insertion loss (when no cell is active) up to -10.15 dB, which is achieved by activating all the three cells. Other interesting states are the ones in which the series resistor in combination with the left of right shunt are active (-7.10 and -6.67 dB respectively), and the ones in which the single series or the right shunt couple of resistors are active (-3.34 and -3.05 dB respectively).

The corresponding return loss curves in Figure 8b are generally satisfactory, except for the higher one that is related to the S21 curve realizing a -3.43 dB attenuation at 25.87 GHz. This is the case in which the only left shunt cell is active. To this regard, the impact of such shunt cell on the return loss curves of the devices can be minimized by further reducing its attenuation. Otherwise, such a problematic state can be avoided, since the device in its current layout already features states attaining attenuations close to that value, as visible in the following Table 2.



(a)



(b)

Figure 8. (a) Attenuation levels introduced by the device in all its states, and (b) return loss curves of the different states. The color of the S21 and S11 curves of a specific state is the same.

Table 2. S-Parameters of the 3-bit attenuator when the RF signal line is loaded (1) or not loaded (0) by the resistors of the different attenuation cells, with reference to the arrangement of Figure 4b.

Shunt Left	Series	Shunt Right	S21 at 25.87 GHz [dB]	S11 at 25.87 GHz [dB]
0	0	0	-1.06	-15.72
0	0	1	-3.05	-11.59
0	1	0	-3.34	-11.60
0	1	1	-6.67	-12.68
1	0	0	-3.43	-9.35
1	0	1	-5.72	-15.49
1	1	0	-7.10	-10.14
1	1	1	-10.15	-11.67

The present layout of the 3-bit reconfigurable attenuator suggests that series and shunt cells can be effectively combined to achieve a fine-tuning attenuation in the range between -1 and -10 dB. If such tuning range must be enlarged up to more substantial base values (e.g., -20, -30 or -40 dB), the present layout can be combined with other combinations of resistors, since the compactness of this layout would not affect sensitively the footprint of the resulting device. At the same time, this 3-bit attenuator could find application in the beamforming of current antenna arrays. As an example, the tapering applied to the radiating elements of the array reported in [39] required normalized excitation amplitudes of 1, 0.9, 0.72, 0.51, and 0.4 for its radiating elements, which correspond to normalized power amplitudes of 0, -0.91, -2.85, -5.84, and -7.95 dB. Such values are quite close to the attenuation levels achieved by the proposed 3-bit attenuator, and even smaller attenuations are needed for the 4x4 and 8x8 arrays reported in [40]. This confirms that, after proper optimization, this reconfigurable attenuator could be employed in real case scenarios.

4. Pi-shaped Attenuation Cells and Concept

As previously mentioned, apart from cascading multiple series and/or shunt cells, in cases where substantial attenuation values are required, an advisable solution consists in the choice of other combined topologies, like T-shaped or Pi-shaped resistors [18]. For this purpose, a basic cell featuring

Pi-shaped resistors inserted along a plain CPW has been optimized to achieve an overall 15 dB attenuation and characterized. As visible in Figure 9a, a 2 mm-long CPW with multi-metal underpass has been considered as basic model, on which a single or multiple compounds of 15 dB Pi-shaped resistors have been placed. Concerning the optimized 15 dB Pi-shaped resistors, they are characterized by a 150 Ohm/Sq sheet resistance, with the series one being $25 \times 106.5 \mu\text{m}^2$, while the shunt ones being $67.5 \times 25 \mu\text{m}^2$.

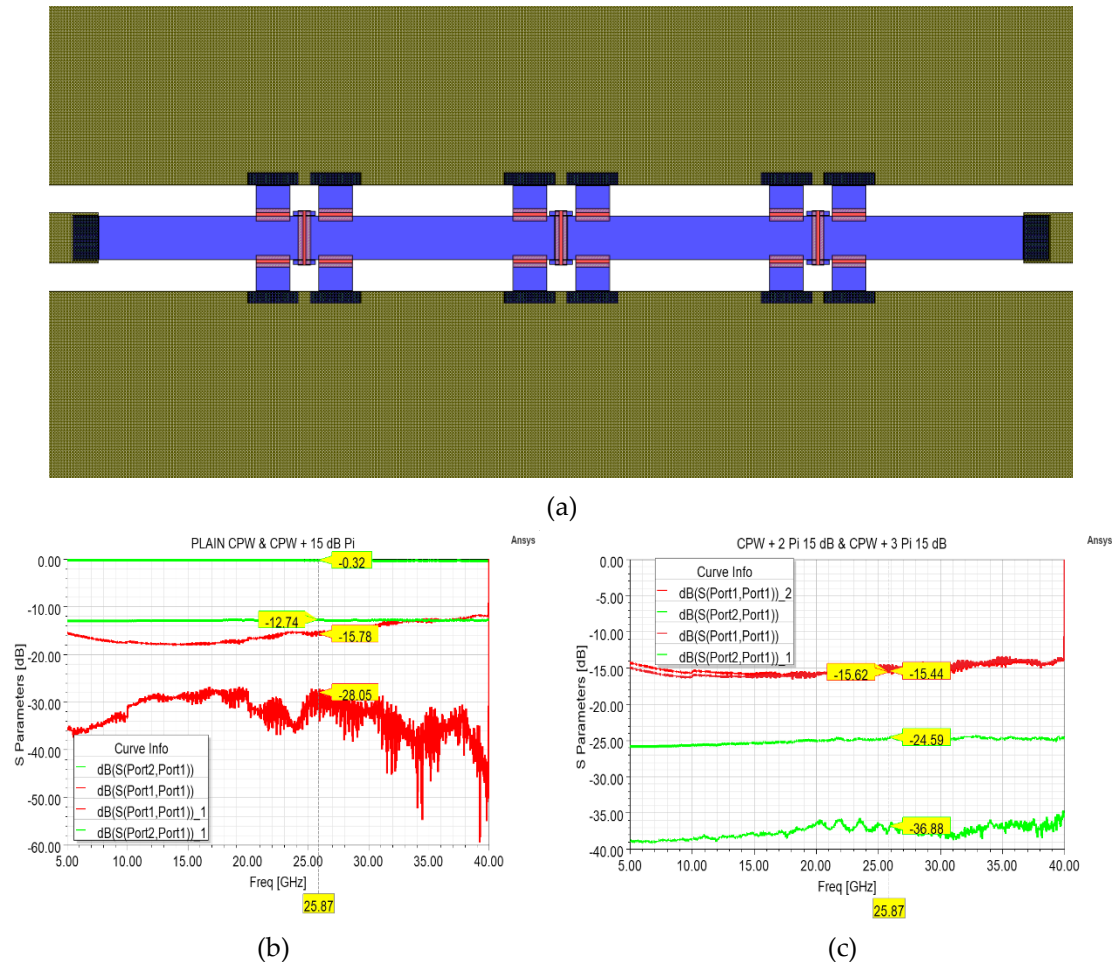


Figure 9. (a) Layout of the CPW transmission line loaded with three cascaded cells of optimized Pi-shaped resistors, aiming at an attenuation level of -45 dB. Return loss (red) and attenuation (green) curves in the (b) comparison between the measurement outcomes of the plain CPW and the CPW loaded with a single -15 dB Pi resistor, and in the (c) comparison between the measurement outcomes of CPW samples loaded with two and three Pi resistors.

Samples of plain CPW and CPW equipped with one, two, and three equally spaced Pi-shaped resistors have been fabricated in a unique batch, and their measurement outcomes are depicted in Figure 9b,c. Regarding the comparison between the plain CPW and the CPW equipped with a single Pi resistor of Figure 9b, it is worth noticing the stable flatness of the reached attenuation, ranging between -12.7 and -13 dB along the 40 GHz interval. In addition, a limited return loss (< -12 dB) can be seen along the whole frequency range. The small discrepancy between the desired (-15 dB) and the achieved attenuation level (~ -13 dB) has repercussion on the attenuation levels obtained by cascading the Pi resistors. In fact, as visible in Figure 9c, two cascaded Pi resistors determined an attenuation of about -25 dB, while the three resistors of Figure 9a led to an attenuation of about -37 dB. Besides the noise ripples affecting the measurements related to the latter case, these two cases also demonstrated remarkably flat attenuation levels and limited return losses, of about -15 dB.

The broadband and stable behavior of such Pi-shaped resistors at high attenuation levels make them a suitable candidate for reconfigurable RF-MEMS attenuators, even combined with the previous

compact attenuator based on series or shunt resistors. In fact, in more complex attenuation networks, the Pi-shaped resistors could be used to set a substantial and coarse attenuation, while additional series or shunt cells could be used for fine-tuning.

The abovementioned Pi-shaped resistors has been adopted to develop the attenuation cell reported in Figure 10a, consisting of an upper branch loaded with the Pi resistors and of a lower and unloaded branch, both selectable by the respective couple of membranes. Concerning the employed membranes, as for some cells detailed in the previous part of this work, a legacy design has been considered, characterized by a more substantial pull-in voltage (~ 45 V) [27]. By such layout of attenuator cell, three useful states can be achieved: the one with the reference unloaded path active, the one with the loaded path active, and the one in which both are active, resulting in the equivalent resistance among the two. This is clearly visible in Figure 10b, where the appreciable attenuation level introduced by the loaded branch is depicted (-13.89 dB at 15 GHz), in combination with the insertion loss of the unloaded branch (-3.82 dB) and the attenuation achieved by activating both (-8.3 dB).

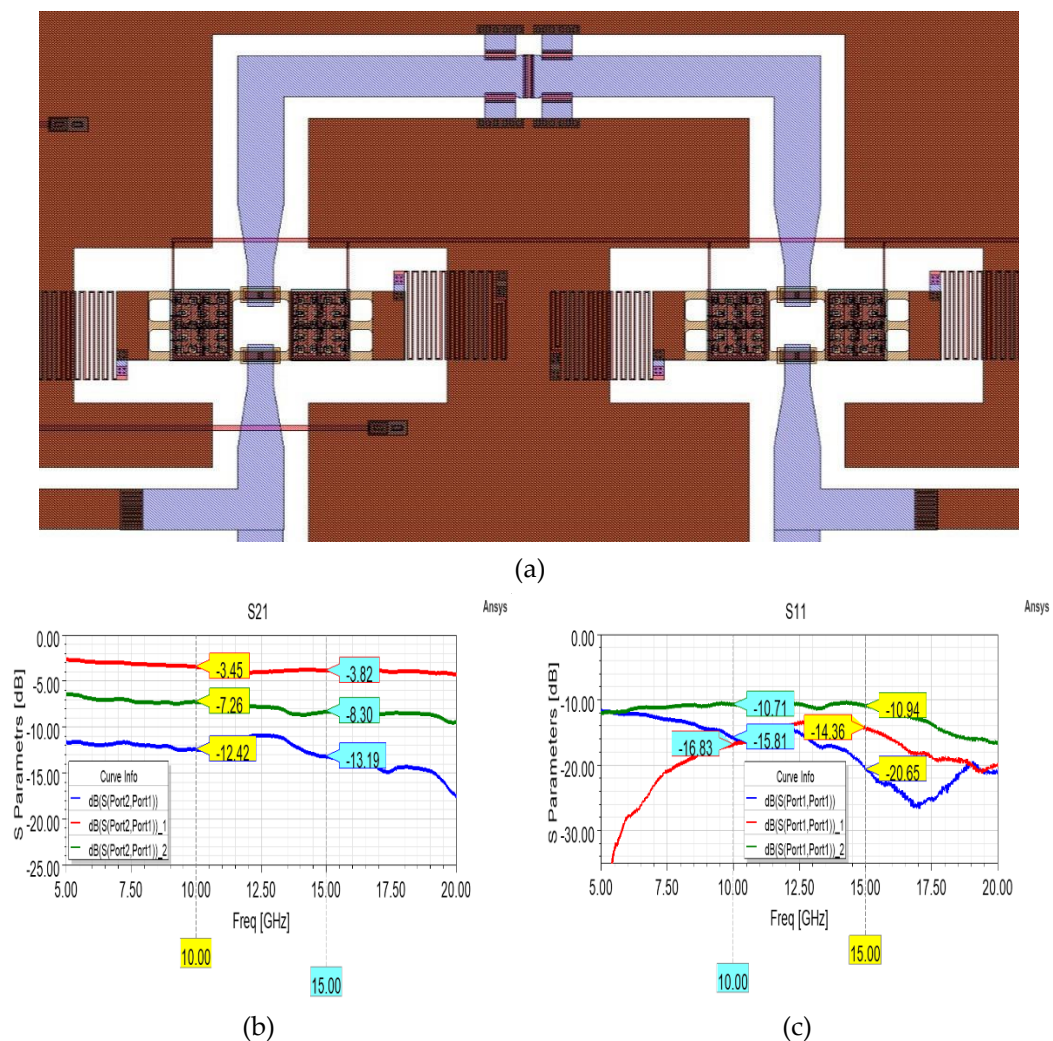


Figure 10. (a) Partial layout of the attenuation cell featuring two branches, detail of the loaded branch. Measured (b) insertion loss of the unloaded branch (in red) and attenuation levels of both the loaded branch (in blue) and the equivalent parallel attenuation (in green), and the (c) related return losses.

It is worth noticing that the stable behavior of the unloaded branch mitigates the ripples of the loaded branch when it is activated in parallel. On the other hand, such ripples (deviating from the flatness observable in Figure 9b) and the non-negligible insertion loss of the unloaded branch can be attributed to a coarse design of the CPW structure. In this regard, the 90° bends of the two branches and T-junctions at both ends should be subject to proper refinements, in order to minimize the

undesired effects deriving from such discontinuities, which are exacerbated at higher frequencies. Despite such limitations in terms of losses, it is possible to notice the limited return losses of Figure 10c, among which the most pronounced is the one related to the parallel activation of the two branches, which suffers the consequences of the mentioned coarse design. Nonetheless, the displayed curves are steadily below -10 dB along the considered interval.

5. Conceptual Design of a 24-state Variable Attenuator

The switched-line attenuation module described in the previous section suggests that, under the premise of a careful design aimed at mitigating the geometrical discontinuities, the discussed Pi-shaped resistors can be effectively combined with the reported 3-bit attenuator. In such monolithic arrangement, the switched-line module would provide the coarse and substantial attenuation, while the 3-bit module would introduce the fine tuning. For this reason, in this section, we describe a configuration of a 24-state variable attenuator based on the combination of the building blocks described in previous sections. As shown by the topology of the concept device described in the following Figure 11, it is possible to combine the switched-line attenuator based on the CPW section with Pi resistor and the 3-bit variable one, through a couple of RF-MEMS-based SPDT switches and sections of CPW lines [41].

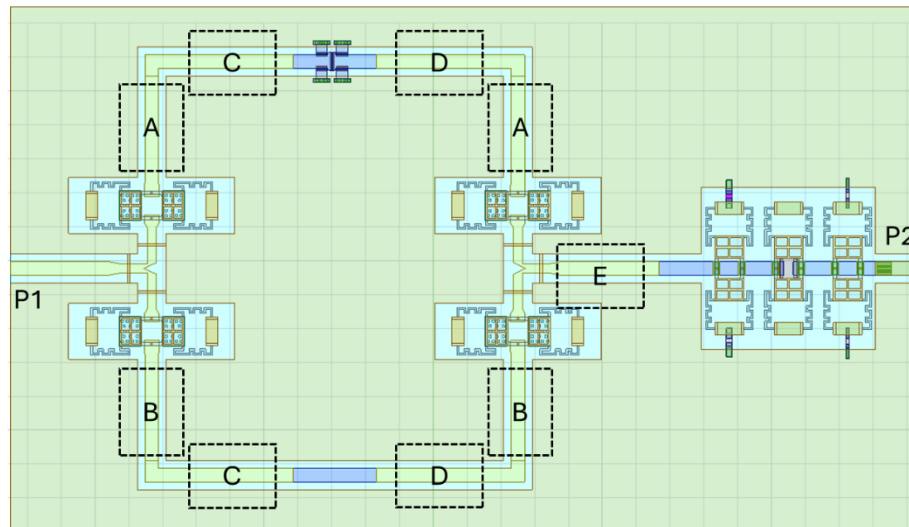


Figure 11. Layout, by principle, of the proposed complete variable attenuator. The dotted boxes identify the sections of CPW lines considered for the final optimization.

The circuit can be subdivided into two macroblocks: the first one contains the two SPDTs through which we can select a negligible attenuation, a fixed and more substantial level of attenuation, and an intermediate attenuation, respectively routing the signal into the unloaded CPW section, the Pi-loaded CPW section, or activating both the routes. For this purpose, two bits would govern such stage of the device. The second block consists of the 3-bit variable attenuation cell. Therefore, the resulting device is operated by 5 control bits.

Each sub-component has its own complex impedance, as shown in Figure 12. That means that when combined, all together the overall input impedance of the final two ports devices must be designed carefully to obtain the desired value and matched with the required ones. In this design, we consider the standard value of 50 Ohm.

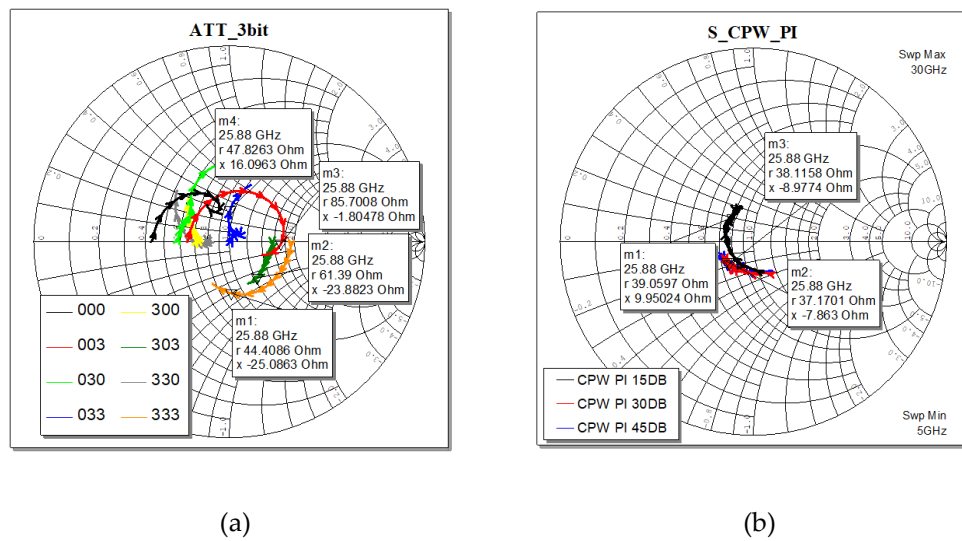


Figure 12. Smith chart representation of the simulated input impedances: (a) all eight states of the 3-bit cell variable attenuator; (b) the three designed Pi-shaped fixed attenuation CPW section.

As visible in Figure 12, the input impedance varies, both in the real and imaginary parts, depending on the selected attenuation level. The markers identify the center band frequency. The effect is more evident when dealing with the 3-bit cell, while the Pi-shaped CPW section is more stable. That effect is unavoidable, depending on the actuation of the series and/or shunt load resistors in the selected state.

To optimize the final layout, as shown in Figure 13, we can define a general and simple strategy, by introducing five sections of straight CPW lines, with the same geometrical parameters and characteristic impedance (50 Ohm). The lengths of those sections are the optimization variables, and the goal of the optimization is the S_{11} of the entire circuit, below -10 dB, within the bandwidth of interest (24.25 GHz – 27.5 GHz). In that schematic the functional blocks, i.e. the SPDTs, the Pi-shaped CPW and the 3-bit attenuator, are described by the S-parameters extracted from a set of EM full-wave 3D simulations; the CPW sections (A,B,C,D,E) and the 90° bends are described by the internal model implemented in the software. The schematic is replicated for each of the states of interest, in Cadence AWR Design Environment 22.1. The lengths of the five CPW sections are defined as global variables of the optimization procedure.

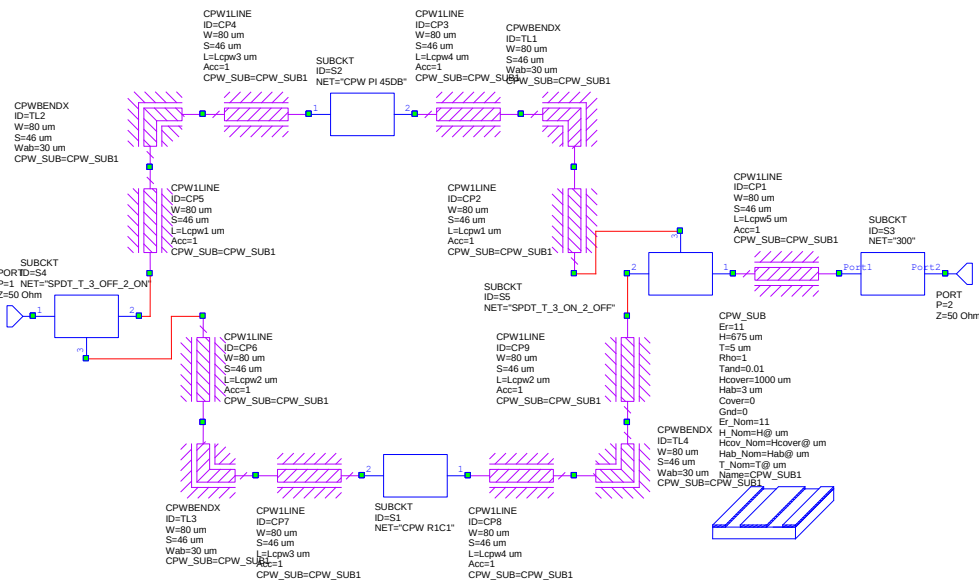


Figure 13. Schematic of the proposed complete variable attenuator in Cadence AWR Design Environment. This figure represents the configuration where the Pi-loaded CPW section is selected by the two SPDTs and the 3-bit cell is set at a state with the maximum attenuation of -10.15 dB.

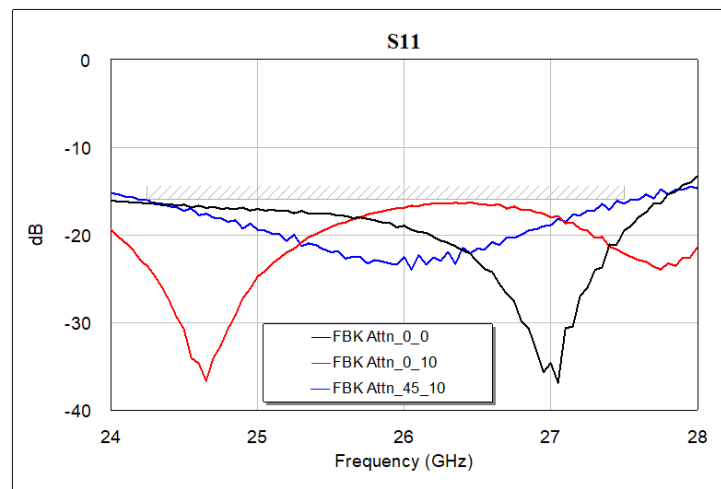
For the sake of brevity, we show the results related to the following configurations:

- SPDTs to select the unloaded CPW section and the 3-bit variable attenuator at -1.06 dB (minimum attenuation), here referred to as Case 1;
- SPDTs to select the unloaded CPW section and the 3-bit variable attenuator at -10.15 dB (maximum attenuation), here referred to as Case 2;
- SPDTs to select the Pi-shaped CPW section with a fixed level of -45 dB of attenuation and the 3-bit variable attenuator at -10.15 dB (maximum attenuation), here referred to as Case 3;

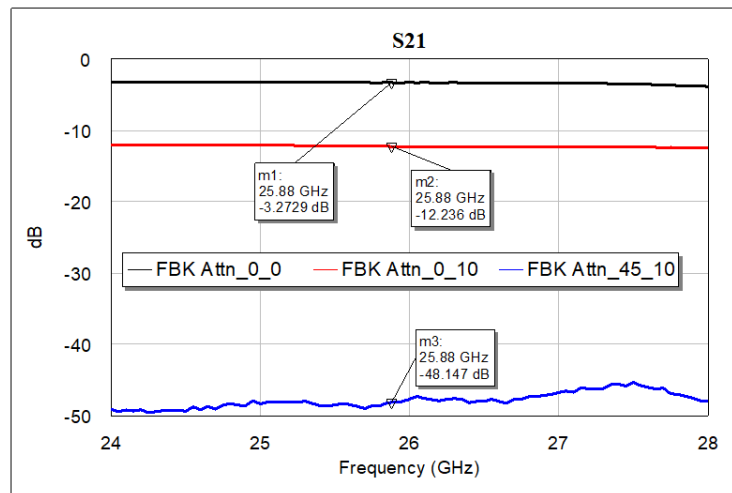
The optimization procedure has been conducted by the built-in Pointer-Hybrid method. It is not possible to know a priori if only one global minimum exists or if the optimization problem possesses various local minima, consequently the obtained solution may be further improved and be not unique, also depending on the constraints of the optimization variables. The calculated optimal solution is based on the following values of the five CPW sections, imposed as variables in the design:

- CPWs "A" with a length of 1964 μm ;
- CPWs "B" with a length of 1 μm ;
- CPWs "C" with a length of 1 μm ;
- CPWs "D" with a length of 844 μm ;
- CPW "E" with a length of 3819 μm .

In the following Figure 14a, the return loss (at port 1) of the complete circuit is reported, as the output of the optimization procedure, and it shows a well-matched device, since the S11 curves lie below -10 dB for the selected attenuation levels. The obtained attenuation levels are displayed in Figure 14b, defined as insertion loss or S21 of the complete circuit.



(a)



(b)

Figure 14. Optimized configuration for the complete attenuator in both its (a) return loss and (b) insertion loss curves, in all the three selected attenuation states: Case 1 (in black), Case 2 (in red), and Case 3 (in blue).

By looking at the electrical features of this simulated arrangement, it is possible to notice that the individual and remarkable return losses characterizing the single modules (loaded and unloaded CPW, 3-bit attenuator and the SPDTs) determine an overall return loss that is steadily below -10 dB along the entire considered interval. Likewise, the flatness of the individual attenuation levels is maintained when the single modules are combined. On the other hand, it is also possible to notice that the described arrangement led to slightly increased losses. In fact, the insertion loss resulting from the Case 1 in the vicinity of 25.87 GHz (-3.27 dB) is greater than the plain sum of the unloaded CPW (-0.32 dB) and the 3-bit attenuator in its state of minimum attenuation (-1.06 dB) at the same frequency. The same applies to Case 2 and 3, where the displayed attenuation levels (-12.23 and -48.17 dB) surpass the sum of the single contributions (-10.47 and -47.03 dB), respectively.

In addition to the remarkable behavior of the displayed curves, it is worth noticing the high reconfigurability of such device, able to attain attenuation levels ranging up to nearly -50 dB by 24 possible states. Despite the reasonably limited losses introduced by the combination of the

abovementioned attenuation modules (that can be mitigated by a further *ad hoc* refinement) such simulated monolithic integration proved the potential of the described modules in providing low-voltage and multi-state RF-MEMS attenuators, providing broadband and flat attenuation levels serving the beamforming architectures of the current and future telecommunications scenario.

6. Conclusions

In this paper, various ideas for reconfigurable RF-MEMS attenuators aimed at beamforming applications are presented. On the basis of the previous part of this work, the 1-bit attenuation modules, which employ series and shunt resistors along with low-voltage membranes (7-9 V), are utilized to create a 3-bit attenuator capable of finely adjusting attenuations (< -10 dB) within the 24.25-27.5 GHz range. Fabricated and tested coplanar waveguide (CPW) sections with Pi-shaped resistors, aiming for attenuations of -15, -30, and -45 dB, displayed remarkable electrical characteristics, including flat attenuation curves and minimal return losses. The adoption of such resistors in a fabricated concept of switched-line attenuator highlighted that Pi-shaped resistors in such switched configuration can effectively provide different substantial and broadband attenuation levels in case of a proper RF design. Based on the promising electromagnetic behavior of the single modules, their integration into a single multi-state device has been simulated. The resulting 24-state device, entirely based on low-voltage membranes, comprises a switched stage devoted to the basic attenuation levels, which can be tuned by the second stage, consisting in the 3-bit attenuator considered initially. The simulated integration confirmed that high attenuation levels (nearly up to -50 dB) can be achieved by such reconfigurable device, without any significant degradation of the whole electromagnetic behavior, given a proper RF design. Since a greater attention has been paid to the impedance matching among the blocks composing the 24-state attenuator ($S_{11} < -11$ dB), at the expense of the current insertion loss (-3.27 dB), further developments concerning such layout will be focused on the minimization of the overall losses of such low-voltage reconfigurable RF-MEMS attenuator concept.

Author Contributions: Conceptualization, G.T. and J.I.; methodology, J.I., R.M., and G.M.S.; software, G.T. and M.M.; validation, G.T., M.M., and F.G.; formal analysis, G.T.; investigation, M.M.; resources, F.G.; data curation, G.T.; writing—original draft preparation, G.T.; writing—review and editing, J.I., F.G., G.M.S., R.M.; visualization, M.M. All authors have read and agreed to the published version of the manuscript.

Funding: This research received no external funding

Data Availability Statement: Data are contained within the article.

Conflicts of Interest: The authors declare no conflicts of interest.

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